



MJ N-Channel Super Trench Power MOSFET

Description

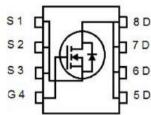
The MJXP0225G uses Super Trench technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of RDS(ON) and Qg. This device is ideal for high-frequency switching and synchronous rectification.

General Features

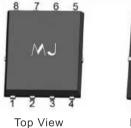
- ◆ Vps=200V lp=25A $R_{DS(ON)}=33m\Omega$ (typical) @ V_{GS}=10V
- ◆ Excellent gate charge x R_{DS(on)} product(FOM)
- ◆ Very low on-resistance R_{DS(on)}
- ◆ 150°C operating temperature
- ◆ Pb-free lead plating

Application

- ◆ DC/DC Converter
- ◆ Ideal for high-frequency switching and synchronous rectification









Schematic Diagram

DFN 5X6

100% UIS TESTED! 100% ΔVds TESTED!

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
P0225G	MJXP0225G	DFN5X6-8L	2	4	-

Absolute Maximum Ratings (T_A=25℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	200	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	lo	25	Α
Drain Current-Continuous(Tc =100°C)	I D(100℃)	17.6	А
Pulsed Drain Current (Note 1)	Ірм	100	А
Maximum Power Dissipation	Po	135	W
Derating factor		1.08	W/°C
Single pulse avalanche energy (Note 5)	Eas	320	mJ
Operating Junction and Storage Temperature Range	Тл ,Тѕтс	-55 To 150	°C

Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2)	Rejc	0.93	°C/W
Thermal Resistance, Junction-to-Ambient (Note 2)	RөJA	50	°C/W





Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			'			
Drain-Source Breakdown Voltage	BVpss	V _{GS} =0V I _D =250µA	200	-	-	V
Zero Gate Voltage Drain Current	loss	V _{DS} =200V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	Igss	V _{DS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250µA	2.5	3.5	4.5	V
Drain-Source On-State Resistance	RDS(ON)	V _{GS} =10V,I _D =20A	-	33	40	mΩ
Forward Transconductance	grs	V _{DS} =5V,I _D =20A	15	-	-	S
Dynamic Characteristics (Note 4)	I		<u> </u>	1		1
Input Capacitance	Ciss	V _{DS} =100V,V _{GS} =0V F=1.0MHz	_	1660	2000	PF
Output Capacitance	Coss		-	130	_	PF
Reverse Transfer Capacitance	Crss		-	5.4	-	PF
Switching Characteristics (Note 4)		ı		ı		
Turn-on Delay Time	t _{d(on)}		-	7	14	nS
Turn-on Rise Time	tr	V _{DD} =100V,R _L =7.5Ω	-	9	16	nS
Turn-Off Delay Time	t _{d(off)}	V _{GS} =10V,R _G =3Ω	-	25	42	nS
Turn-Off Fall Time	tr		-	5	9	nS
Total Gate Charge	Q_g	V _{DS} =100V,I _D =20A V _{GS} =10V	-	28	36	nC
Gate-Source Charge	Qgs		_	11	14	nC
Gate-Drain Charge	Qgd		-	5.9	8	nC
Drain-Source Diode Characteristics					<u> </u>	<u> </u>
Diode Forward Voltage (Note 3)	VsD	V _{GS} =0V,I _S =20A	_	_	1.2	V
Diode Forward Current (Note 2)	Is		-	-	25	А
Reverse Recovery Time	t _{rr}	T. 0500 I	_	45	_	nS
Reverse Recovery Charge	Qrr	TJ=25°C, IF=Is di/dt=100A/µs (Note 3)	_	160	_	nC

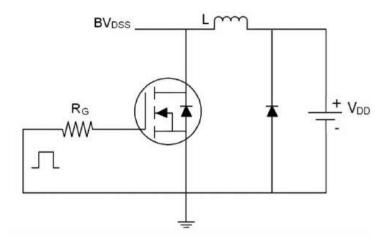
Notes:

- 1) Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- ③ Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4 Guaranteed by design, not subject to production
- 5 EAS condition: Tj=25°C,Vpp=50V,Vg=10V,L=0.5mH,Rg=25 Ω

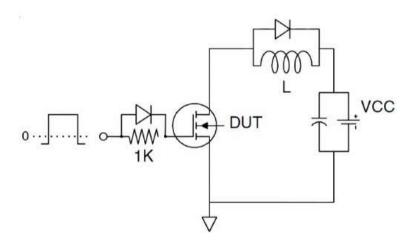




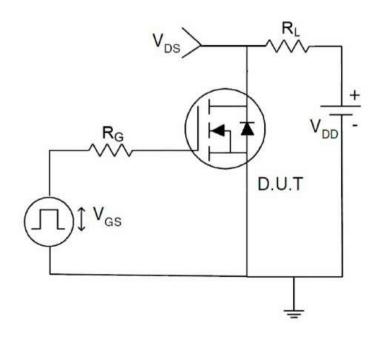
Test circuit



Eas test Circuit



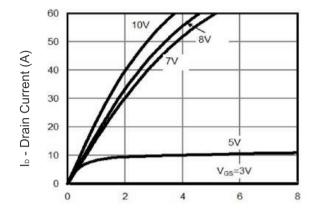
Gate charge test Circuit



Switch Time Test Circuit



Typical Electrical and Thermal Characteristics



Vds Drain-Source Voltage (V)



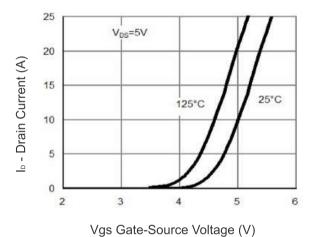


Figure 2 Transfer Characteristics

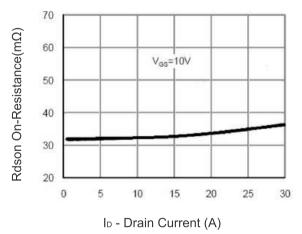
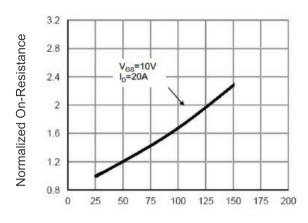
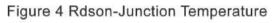


Figure 3 Rdson- Drain Current



T_J -Junction Temperature(°C)



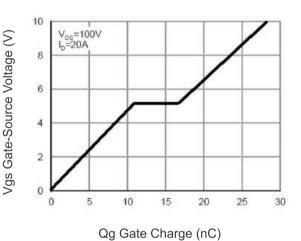
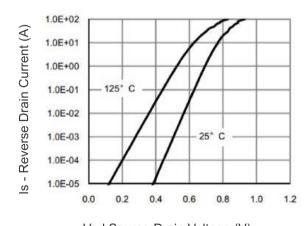


Figure 5 Gate Charge



Vsd Source-Drain Voltage (V) Figure 6 Source- Drain Diode Forward



I_D - Drain Current (A)



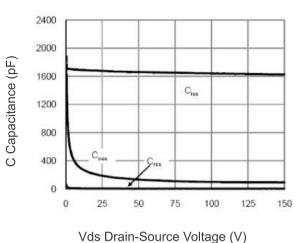
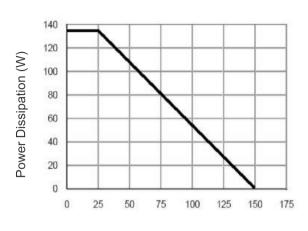


Figure 7 Capacitance vs Vds



T_J -Junction Temperature(°C) Figure 9 Power De-rating

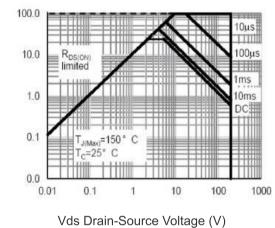
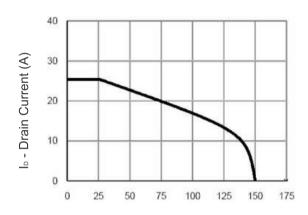
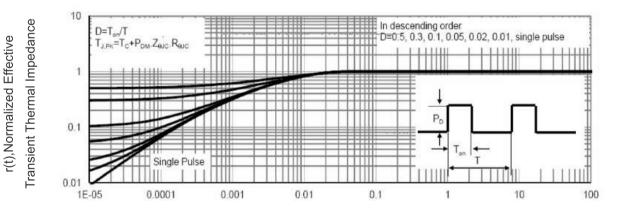


Figure 8 Safe Operation Area



T_J -Junction Temperature(°C)
Figure 10 Current De-rating



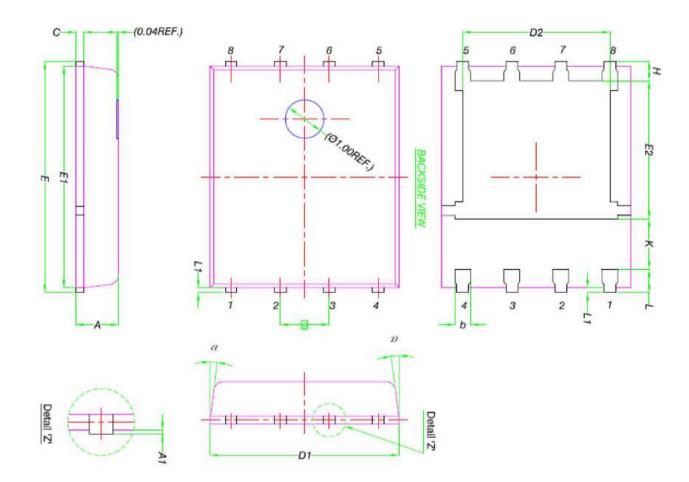
Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance

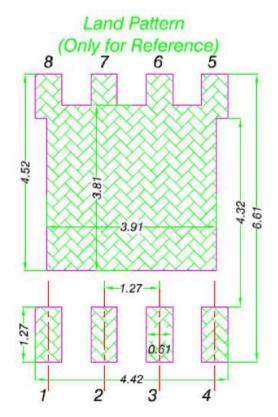




DFN5X6-8L Package Information



DIM.	MILLIMETERS				
	MIN.	NOM.	MAX.		
Α	0.90	1.00	1.10		
A1	0	•	0.05		
b	0.33	0.41	0.51		
С	0.20	0.25	0.30		
D1	4.80	4.90	5.00		
D2	3.61	3.81	3.96		
Ε	5.90	6.00	6.10		
E1	5.70	5.75	5.80		
E2	3.38	3.58	3.78		
е	1.27 BSC				
Н	0.41	0.51	0.61		
K	1.10	*	*		
L	0.51	0.61	0.71		
L1	0.06	0.13	0.20		
α	O°		129		







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